

### FEATURES

High common-mode transient immunity: 100 kV/ $\mu$ s typical

High robustness to radiated and conducted noise

Low propagation delay

13 ns maximum for 5 V operation

15 ns maximum for 1.8 V operation

150 Mbps minimum data rate

Safety and regulatory approvals

UL recognition: 3000 V rms for 1 minute per UL 1577

CSA Component Acceptance Notice 5A

VDE certificate of conformity

DIN VDE V 0884-11:2017-01

$V_{IORM} = 565$  V peak

CQC certification per GB4943.1-2011

Backward compatibility

ADuM120N0 pin-compatible with ADuM1285

ADuM120N1 pin-compatible with ADuM1280 and

ADuM1200

ADuM121N0 pin-compatible with ADuM1286

ADuM121N1 pin-compatible with ADuM1281 and

ADuM1201

Low dynamic power consumption

1.8 V to 5 V level translation

High temperature operation: 125°C

Failsafe high or low options

8-lead, RoHS-compliant, SOIC package

Qualified for automotive applications

### APPLICATIONS

General-purpose multichannel isolation

Industrial field bus isolation

### GENERAL DESCRIPTION

The ADuM120N/ADuM121N<sup>1</sup> are dual-channel digital isolators based on Analog Devices, Inc., iCoupler® technology. Combining high speed, complementary metal-oxide semiconductor (CMOS) and monolithic air core transformer technology, these isolation components provide outstanding performance characteristics superior to alternatives such as optocoupler devices and other integrated couplers. The maximum propagation delay is 13 ns with a pulse width distortion of less than 3 ns at 5 V operation. Channel matching is tight at 3.0 ns maximum.

The ADuM120N/ADuM121N data channels are independent and are available in a variety of configurations with a withstand voltage rating of 3 kV rms (see the Ordering Guide). The devices operate with the supply voltage on either side ranging from 1.8 V to 5 V,

### FUNCTIONAL BLOCK DIAGRAMS

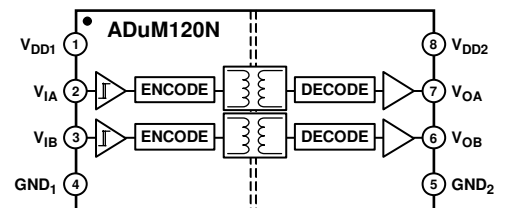


Figure 1. ADuM120N Functional Block Diagram

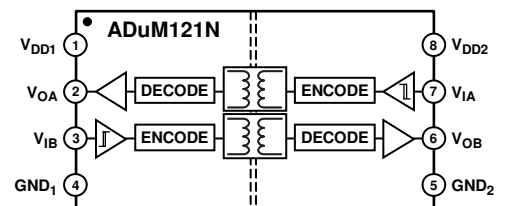


Figure 2. ADuM121N Functional Block Diagram

providing compatibility with lower voltage systems as well as enabling voltage translation functionality across the isolation barrier.

Unlike other optocoupler alternatives, dc correctness is ensured in the absence of input logic transitions. Two different fail-safe options are available in which the outputs transition to a predetermined state when the input power supply is not applied or the inputs are disabled.

The ADuM120N0 is pin-compatible with the ADuM1285, and the ADuM120N1 is pin-compatible with the ADuM1280 and the ADuM1200. The ADuM121N0 is pin-compatible with ADuM1286, and the ADuM121N1 is pin-compatible with the ADuM1281 and the ADuM1201.

<sup>1</sup> Protected by U.S. Patents 5,952,849; 6,873,065; 6,903,578; and 7,075,329. Other patents are pending.

Rev. E

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## REVISION HISTORY

### 11/2021—Rev. D to Rev. E

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| Changed to DIN V VDE V 0884-10 to<br>DIN VDE V 0884-11.....   | Throughout |
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### 9/2017—Rev. B to Rev. C

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### 9/2016—Rev. A to Rev. B

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### 4/2016—Rev. 0 to Rev. A

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| Added Automotive Products Section.....     | 19 |

### 1/2016—Revision 0: Initial Version

## SPECIFICATIONS

## ELECTRICAL CHARACTERISTICS—5 V OPERATION

All typical specifications are at  $T_A = 25^\circ\text{C}$ ,  $V_{DD1} = V_{DD2} = 5\text{ V}$ . Minimum/maximum specifications apply over the entire recommended operation range of  $4.5\text{ V} \leq V_{DD1} \leq 5.5\text{ V}$ ,  $4.5\text{ V} \leq V_{DD2} \leq 5.5\text{ V}$ , and  $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ , unless otherwise noted. Switching specifications are tested with  $C_L = 15\text{ pF}$  and CMOS signal levels, unless otherwise noted. Supply currents are specified with 50% duty cycle signals.

Table 1.

| Parameter                       | Symbol             | Min                  | Typ             | Max                  | Unit                 | Test Conditions/Comments   |
|---------------------------------|--------------------|----------------------|-----------------|----------------------|----------------------|--|
| <b>SWITCHING SPECIFICATIONS</b> |                    |                      |                 |                      |                      |  |
| Pulse Width                     | PW                 | 6.6                  |                 |                      | ns                   | Within pulse width distortion (PWD) limit                        |
| Data Rate                       |                    | 150                  |                 |                      | Mbps                 | Within PWD limit   |
| Propagation Delay               | $t_{PHL}, t_{PLH}$ | 4.8                  | 7.2             | 13                   | ns                   | 50% input to 50% output  |
| Pulse Width Distortion          | PWD                |                      | 0.5             | 3                    | ns                   | $ t_{PLH} - t_{PHL} $  |
| Change vs. Temperature          |                    |                      | 1.5             |                      | ps/ $^\circ\text{C}$ |  |
| Propagation Delay Skew          | $t_{PSK}$          |                      |                 | 6.0                  | ns                   | Between any two units at the same temperature, voltage, and load |
| Channel Matching                |                    |                      |                 |                      |                      |  |
| Codirectional                   | $t_{PSKCD}$        |                      | 0.5             | 3.0                  | ns                   |  |
| Opposing Direction              | $t_{PSKOD}$        |                      | 0.5             | 3.0                  | ns                   |  |
| Jitter                          |                    |                      | 380             |                      | ps p-p               | See the Jitter Measurement section                               |
|                                 |                    |                      | 55              |                      | ps rms               | See the Jitter Measurement section                               |
| <b>DC SPECIFICATIONS</b>        |                    |                      |                 |                      |                      |  |
| Input Threshold Voltage         |                    |                      |                 |                      |                      |  |
| Logic High                      | $V_{IH}$           | $0.7 \times V_{DDx}$ |                 |                      | V                    |  |
| Logic Low                       | $V_{IL}$           |                      |                 | $0.3 \times V_{DDx}$ | V                    |  |
| Output Voltage                  |                    |                      |                 |                      |                      |  |
| Logic High                      | $V_{OH}$           | $V_{DDx} - 0.1$      | $V_{DDx}$       |                      | V                    | $I_{Ox}^1 = -20\text{ }\mu\text{A}, V_{Ix} = V_{IxH}^2$          |
|                                 |                    | $V_{DDx} - 0.4$      | $V_{DDx} - 0.2$ |                      | V                    | $I_{Ox}^1 = -4\text{ mA}, V_{Ix} = V_{IxH}^2$                    |
| Logic Low                       | $V_{OL}$           |                      | 0.0             | 0.1                  | V                    | $I_{Ox}^1 = 20\text{ }\mu\text{A}, V_{Ix} = V_{IxL}^3$           |
|                                 |                    |                      | 0.2             | 0.4                  | V                    | $I_{Ox}^1 = 4\text{ mA}, V_{Ix} = V_{IxL}^3$                     |
| Input Current per Channel       | $I_i$              | -10                  | +0.01           | +10                  | $\mu\text{A}$        | $0\text{ V} \leq V_{Ix} \leq V_{DDx}$                            |
| Quiescent Supply Current        |                    |                      |                 |                      |                      |  |
| ADuM120N                        |                    |                      |                 |                      |                      |  |
| $I_{DD1(Q)}$                    |                    |                      | 0.9             | 1.3                  | mA                   | $V_I^4 = 0\text{ (NO)}, 1\text{ (N1)}^5$                         |
| $I_{DD2(Q)}$                    |                    |                      | 1.3             | 1.8                  | mA                   | $V_I^4 = 0\text{ (NO)}, 1\text{ (N1)}^5$                         |
| $I_{DD1(Q)}$                    |                    |                      | 6.4             | 10.0                 | mA                   | $V_I^4 = 1\text{ (NO)}, 0\text{ (N1)}^5$                         |
| $I_{DD2(Q)}$                    |                    |                      | 1.4             | 1.9                  | mA                   | $V_I^4 = 1\text{ (NO)}, 0\text{ (N1)}^5$                         |
| ADuM121N                        |                    |                      |                 |                      |                      |  |
| $I_{DD1(Q)}$                    |                    |                      | 1.1             | 1.6                  | mA                   | $V_I^4 = 0\text{ (NO)}, 1\text{ (N1)}^5$                         |
| $I_{DD2(Q)}$                    |                    |                      | 1.1             | 1.5                  | mA                   | $V_I^4 = 0\text{ (NO)}, 1\text{ (N1)}^5$                         |
| $I_{DD1(Q)}$                    |                    |                      | 4.0             | 5.8                  | mA                   | $V_I^4 = 1\text{ (NO)}, 0\text{ (N1)}^5$                         |
| $I_{DD2(Q)}$                    |                    |                      | 4.9             | 6.4                  | mA                   | $V_I^4 = 1\text{ (NO)}, 0\text{ (N1)}^5$                         |
| Dynamic Supply Current          |                    |                      |                 |                      |                      |  |
| Dynamic Input                   | $I_{DDI(D)}$       |                      | 0.01            |                      | mA/Mbps              | Inputs switching, 50% duty cycle                                 |
| Dynamic Output                  | $I_{DDO(D)}$       |                      | 0.02            |                      | mA/Mbps              | Inputs switching, 50% duty cycle                                 |
| Undervoltage Lockout            | UVLO               |                      |                 |                      |                      |  |
| Positive $V_{DDx}$ Threshold    | $V_{DDxUV+}$       |                      | 1.6             |                      | V                    |  |
| Negative $V_{DDx}$ Threshold    | $V_{DDxUV-}$       |                      | 1.5             |                      | V                    |  |
| $V_{DDx}$ Hysteresis            | $V_{DDxUVH}$       |                      | 0.1             |                      | V                    |  |

| Parameter                                   | Symbol    | Min | Typ | Max | Unit        | Test Conditions/Comments  |
|---|-----------|-----|-----|-----|-------------|---|
| AC SPECIFICATIONS                           |           |     |     |     |             |   |
| Output Rise/Fall Time                       | $t_R/t_F$ |     | 2.5 |     | ns          | 10% to 90%  |
| Common-Mode Transient Immunity <sup>6</sup> | $ CM_H $  | 75  | 100 |     | kV/ $\mu$ s | $V_{ix} = V_{DDx}$ , $V_{CM} = 1000$ V, transient magnitude = 800 V |
|   | $ CM_L $  | 75  | 100 |     | kV/ $\mu$ s | $V_{ix} = 0$ V, $V_{CM} = 1000$ V, transient magnitude = 800 V      |

<sup>1</sup>  $I_{Ox}$  is the Channel x output current, where x = A or B.

<sup>2</sup>  $V_{IH}$  is the input side logic high voltage.

<sup>3</sup>  $V_{IL}$  is the input side logic low voltage.

<sup>4</sup>  $V_i$  is the input voltage.

<sup>5</sup> N0 is the ADuM120N0/ADuM121N0 models, and N1 is the ADuM120N1/ADuM121N1 models. See the Ordering Guide.

<sup>6</sup>  $|CM_H|$  is the maximum common-mode voltage slew rate that can be sustained while maintaining the voltage output ( $V_o$ ) > 0.8  $V_{DDx}$ .  $|CM_L|$  is the maximum common-mode voltage slew rate that can be sustained while maintaining  $V_o$  > 0.8 V. The common-mode voltage slew rates apply to both rising and falling common-mode voltage edges.

**Table 2. Total Supply Current vs. Data Throughput**

| Parameter             | Symbol    | Min | 1 Mbps |     | 25 Mbps |     | 100 Mbps |     | Unit |     |     |
|-----------------------|-----------|-----|--------|-----|---------|-----|----------|-----|------|-----|-----|
|                       |           |     | Typ    | Max | Min     | Typ | Max      | Min |      | Typ | Max |
| SUPPLY CURRENT        |           |     |        |     |         |     |          |     |      |     |     |
| ADuM120N              |           |     |        |     |         |     |          |     |      |     |     |
| Supply Current Side 1 | $I_{DD1}$ |     | 3.7    | 6.8 |         | 4.2 | 7.2      |     | 6.2  | 9.3 | mA  |
| Supply Current Side 2 | $I_{DD2}$ |     | 1.4    | 2.0 |         | 2.5 | 3.2      |     | 6.0  | 8.1 | mA  |
| ADuM121N              |           |     |        |     |         |     |          |     |      |     |     |
| Supply Current Side 1 | $I_{DD1}$ |     | 2.6    | 4.5 |         | 3.2 | 5.4      |     | 5.4  | 8.2 | mA  |
| Supply Current Side 2 | $I_{DD2}$ |     | 3.0    | 4.9 |         | 3.7 | 5.9      |     | 5.8  | 8.6 | mA  |

**ELECTRICAL CHARACTERISTICS—3.3 V OPERATION**

All typical specifications are at  $T_A = 25^\circ\text{C}$ ,  $V_{DD1} = V_{DD2} = 3.3\text{ V}$ . Minimum/maximum specifications apply over the entire recommended operation range:  $3.0\text{ V} \leq V_{DD1} \leq 3.6\text{ V}$ ,  $3.0\text{ V} \leq V_{DD2} \leq 3.6\text{ V}$ , and  $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ , unless otherwise noted. Switching specifications are tested with  $C_L = 15\text{ pF}$  and CMOS signal levels, unless otherwise noted. Supply currents are specified with 50% duty cycle signals.

**Table 3.**

| Parameter                       | Symbol             | Min                  | Typ             | Max                  | Unit                 | Test Conditions/Comments   |
|---------------------------------|--------------------|----------------------|-----------------|----------------------|----------------------|--|
| <b>SWITCHING SPECIFICATIONS</b> |                    |                      |                 |                      |                      |  |
| Pulse Width                     | PW                 | 6.6                  |                 |                      | ns                   | Within PWD limit   |
| Data Rate                       |                    | 150                  |                 |                      | Mbps                 | Within PWD limit   |
| Propagation Delay               | $t_{PHL}, t_{PLH}$ | 4.8                  | 6.8             | 14                   | ns                   | 50% input to 50% output  |
| Pulse Width Distortion          | PWD                |                      | 0.7             | 3                    | ns                   | $ t_{PLH} - t_{PHL} $  |
| Change vs. Temperature          |                    |                      | 1.5             |                      | ps/ $^\circ\text{C}$ |  |
| Propagation Delay Skew          | $t_{PSK}$          |                      |                 | 7.0                  | ns                   | Between any two units at the same temperature, voltage, and load |
| Channel Matching                |                    |                      |                 |                      |                      |  |
| Codirectional                   | $t_{PSKCD}$        |                      | 0.7             | 3.0                  | ns                   |  |
| Opposing Direction              | $t_{PSKOD}$        |                      | 0.7             | 3.0                  | ns                   |  |
| Jitter                          |                    |                      | 290             |                      | ps p-p               | See the Jitter Measurement section                               |
|                                 |                    |                      | 45              |                      | ps rms               | See the Jitter Measurement section                               |
| <b>DC SPECIFICATIONS</b>        |                    |                      |                 |                      |                      |  |
| Input Threshold Voltage         |                    |                      |                 |                      |                      |  |
| Logic High                      | $V_{IH}$           | $0.7 \times V_{DDx}$ |                 |                      | V                    |  |
| Logic Low                       | $V_{IL}$           |                      |                 | $0.3 \times V_{DDx}$ | V                    |  |
| Output Voltage                  |                    |                      |                 |                      |                      |  |
| Logic High                      | $V_{OH}$           | $V_{DDx} - 0.1$      | $V_{DDx}$       |                      | V                    | $I_{Ox}^1 = -20\ \mu\text{A}, V_{Ix} = V_{IxH}^2$                |
|                                 |                    | $V_{DDx} - 0.4$      | $V_{DDx} - 0.2$ |                      | V                    | $I_{Ox}^1 = -2\ \text{mA}, V_{Ix} = V_{IxH}^2$                   |
| Logic Low                       | $V_{OL}$           |                      | 0.0             | 0.1                  | V                    | $I_{Ox}^1 = 20\ \mu\text{A}, V_{Ix} = V_{IxL}^3$                 |
|                                 |                    |                      | 0.2             | 0.4                  | V                    | $I_{Ox}^1 = 2\ \text{mA}, V_{Ix} = V_{IxL}^3$                    |
| Input Current per Channel       | $I_i$              | -10                  | +0.01           | +10                  | $\mu\text{A}$        | $0\text{ V} \leq V_{Ix} \leq V_{DDx}$                            |
| Quiescent Supply Current        |                    |                      |                 |                      |                      |  |
| ADuM120N                        |                    |                      |                 |                      |                      |  |
| $I_{DD1(Q)}$                    |                    |                      | 0.8             | 1.3                  | mA                   | $V_i^4 = 0\ (N0), 1\ (N1)^5$                                     |
| $I_{DD2(Q)}$                    |                    |                      | 1.2             | 1.8                  | mA                   | $V_i^4 = 0\ (N0), 1\ (N1)^5$                                     |
| $I_{DD1(Q)}$                    |                    |                      | 6.3             | 9.7                  | mA                   | $V_i^4 = 1\ (N0), 0\ (N1)^5$                                     |
| $I_{DD2(Q)}$                    |                    |                      | 1.3             | 1.8                  | mA                   | $V_i^4 = 1\ (N0), 0\ (N1)^5$                                     |
| ADuM121N                        |                    |                      |                 |                      |                      |  |
| $I_{DD1(Q)}$                    |                    |                      | 1.0             | 1.6                  | mA                   | $V_i^4 = 0\ (N0), 1\ (N1)^5$                                     |
| $I_{DD2(Q)}$                    |                    |                      | 1.0             | 1.5                  | mA                   | $V_i^4 = 01\ (N0), 1\ (N1)^5$                                    |
| $I_{DD1(Q)}$                    |                    |                      | 3.9             | 5.8                  | mA                   | $V_i^4 = 1\ (N0), 0\ (N1)^5$                                     |
| $I_{DD2(Q)}$                    |                    |                      | 4.8             | 6.4                  | mA                   | $V_i^4 = 1\ (N0), 0\ (N1)^5$                                     |
| Dynamic Supply Current          |                    |                      |                 |                      |                      |  |
| Dynamic Input                   | $I_{DDI(D)}$       |                      | 0.01            |                      | mA/Mbps              | Inputs switching, 50% duty cycle                                 |
| Dynamic Output                  | $I_{DDO(D)}$       |                      | 0.01            |                      | mA/Mbps              | Inputs switching, 50% duty cycle                                 |
| Undervoltage Lockout            | UVLO               |                      |                 |                      |                      |  |
| Positive $V_{DDx}$ Threshold    | $V_{DDxUV+}$       |                      | 1.6             |                      | V                    |  |
| Negative $V_{DDx}$ Threshold    | $V_{DDxUV-}$       |                      | 1.5             |                      | V                    |  |
| $V_{DDx}$ Hysteresis            | $V_{DDxUVH}$       |                      | 0.1             |                      | V                    |  |

| Parameter                                   | Symbol    | Min | Typ | Max | Unit        | Test Conditions/Comments  |
|---|-----------|-----|-----|-----|-------------|---|
| AC SPECIFICATIONS                           |           |     |     |     |             |   |
| Output Rise/Fall Time                       | $t_R/t_F$ |     | 2.5 |     | ns          | 10% to 90%  |
| Common-Mode Transient Immunity <sup>6</sup> | $ CM_H $  | 75  | 100 |     | kV/ $\mu$ s | $V_{IX} = V_{DDX}$ , $V_{CM} = 1000$ V, transient magnitude = 800 V |
|   | $ CM_L $  | 75  | 100 |     | kV/ $\mu$ s | $V_{IX} = 0$ V, $V_{CM} = 1000$ V, transient magnitude = 800 V      |

<sup>1</sup>  $I_{Ox}$  is the Channel x output current, where x = A or B.

<sup>2</sup>  $V_{IH}$  is the input side logic high voltage.

<sup>3</sup>  $V_{IL}$  is the input side logic low voltage.

<sup>4</sup>  $V_i$  is the input voltage.

<sup>5</sup> N0 is the ADuM120N0/ADuM121N0 models, and N1 is the ADuM120N1/ADuM121N1 models. See the Ordering Guide.

<sup>6</sup>  $|CM_H|$  is the maximum common-mode voltage slew rate that can be sustained while maintaining  $V_O > 0.8 V_{DDX}$ .  $|CM_L|$  is the maximum common-mode voltage slew rate that can be sustained while maintaining  $V_O > 0.8$  V. The common-mode voltage slew rates apply to both rising and falling common-mode voltage edges.

**Table 4. Total Supply Current vs. Data Throughput**

| Parameter             | Symbol    | 1 Mbps |     |     | 25 Mbps |     |     | 100 Mbps |     |     | Unit |
|-----------------------|-----------|--------|-----|-----|---------|-----|-----|----------|-----|-----|------|
|                       |           | Min    | Typ | Max | Min     | Typ | Max | Min      | Typ | Max |      |
| SUPPLY CURRENT        |           |        |     |     |         |     |     |          |     |     |      |
| ADuM120N              |           |        |     |     |         |     |     |          |     |     |      |
| Supply Current Side 1 | $I_{DD1}$ |        | 3.6 | 6.2 |         | 4.0 | 6.7 |          | 5.6 | 9.1 | mA   |
| Supply Current Side 2 | $I_{DD2}$ |        | 1.3 | 1.9 |         | 2.3 | 3.1 |          | 5.2 | 6.8 | mA   |
| ADuM121N              |           |        |     |     |         |     |     |          |     |     |      |
| Supply Current Side 1 | $I_{DD1}$ |        | 2.5 | 4.6 |         | 3.0 | 5.5 |          | 5.0 | 8.1 | mA   |
| Supply Current Side 2 | $I_{DD2}$ |        | 2.9 | 4.8 |         | 3.5 | 5.8 |          | 5.4 | 8.3 | mA   |

**ELECTRICAL CHARACTERISTICS—2.5 V OPERATION**

All typical specifications are at  $T_A = 25^\circ\text{C}$ ,  $V_{DD1} = V_{DD2} = 2.5\text{ V}$ . Minimum/maximum specifications apply over the entire recommended operation range:  $2.25\text{ V} \leq V_{DD1} \leq 2.75\text{ V}$ ,  $2.25\text{ V} \leq V_{DD2} \leq 2.75\text{ V}$ ,  $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ , unless otherwise noted. Switching specifications are tested with  $C_L = 15\text{ pF}$  and CMOS signal levels, unless otherwise noted. Supply currents are specified with 50% duty cycle signals.

Table 5.

| Parameter                       | Symbol                | Min                  | Typ             | Max                  | Unit                 | Test Conditions/Comments                                     |
|---------------------------------|-----------------------|----------------------|-----------------|----------------------|----------------------|--|
| <b>SWITCHING SPECIFICATIONS</b> |                       |                      |                 |                      |                      |  |
| Pulse Width                     | PW                    | 6.6                  |                 |                      | ns                   | Within PWD limit   |
| Data Rate                       |                       | 150                  |                 |                      | Mbps                 | Within PWD limit   |
| Propagation Delay               | $t_{PHL}$ , $t_{PLH}$ | 5.0                  | 7.0             | 14                   | ns                   | 50% input to 50% output                                      |
| Pulse Width Distortion          | PWD                   |                      | 0.7             | 3                    | ns                   | $ t_{PLH} - t_{PHL} $  |
| Change vs. Temperature          |                       |                      | 1.5             |                      | ps/ $^\circ\text{C}$ |  |
| Propagation Delay Skew          | $t_{PSK}$             |                      |                 | 7.0                  | ns                   | Between any two units at the same temperature, voltage, load |
| Channel Matching                |                       |                      |                 |                      |                      |  |
| Codirectional                   | $t_{PSKCD}$           |                      | 0.7             | 3.0                  | ns                   |  |
| Opposing Direction              | $t_{PSKOD}$           |                      | 0.7             | 3.0                  | ns                   |  |
| Jitter                          |                       |                      | 320             |                      | ps p-p               | See the Jitter Measurement section                           |
|                                 |                       |                      | 65              |                      | ps rms               | See the Jitter Measurement section                           |
| <b>DC SPECIFICATIONS</b>        |                       |                      |                 |                      |                      |  |
| Input Threshold Voltage         |                       |                      |                 |                      |                      |  |
| Logic High                      | $V_{IH}$              | $0.7 \times V_{DDx}$ |                 |                      | V                    |  |
| Logic Low                       | $V_{IL}$              |                      |                 | $0.3 \times V_{DDx}$ | V                    |  |
| Output Voltage                  |                       |                      |                 |                      |                      |  |
| Logic High                      | $V_{OH}$              | $V_{DDx} - 0.1$      | $V_{DDx}$       |                      | V                    | $I_{Ox}^1 = -20\ \mu\text{A}$ , $V_{Ix} = V_{IxH}^2$         |
|                                 |                       | $V_{DDx} - 0.4$      | $V_{DDx} - 0.2$ |                      | V                    | $I_{Ox}^1 = -2\ \text{mA}$ , $V_{Ix} = V_{IxH}^2$            |
| Logic Low                       | $V_{OL}$              |                      | 0.0             | 0.1                  | V                    | $I_{Ox}^1 = 20\ \mu\text{A}$ , $V_{Ix} = V_{IxL}^3$          |
|                                 |                       |                      | 0.2             | 0.4                  | V                    | $I_{Ox}^1 = 2\ \text{mA}$ , $V_{Ix} = V_{IxL}^3$             |
| Input Current per Channel       | $I_i$                 | -10                  | +0.01           | +10                  | $\mu\text{A}$        | $0\text{ V} \leq V_{Ix} \leq V_{DDx}$                        |
| Quiescent Supply Current        |                       |                      |                 |                      |                      |  |
| ADuM120N                        |                       |                      |                 |                      |                      |  |
| $I_{DD1(Q)}$                    |                       |                      | 0.8             | 1.2                  | mA                   | $V_I^4 = 0\text{ (NO)}$ , $1\text{ (N1)}^5$                  |
| $I_{DD2(Q)}$                    |                       |                      | 1.2             | 1.8                  | mA                   | $V_I^4 = 0\text{ (NO)}$ , $1\text{ (N1)}^5$                  |
| $I_{DD1(Q)}$                    |                       |                      | 6.2             | 9.5                  | mA                   | $V_I^4 = 1\text{ (NO)}$ , $0\text{ (N1)}^5$                  |
| $I_{DD2(Q)}$                    |                       |                      | 1.3             | 1.8                  | mA                   | $V_I^4 = 1\text{ (NO)}$ , $0\text{ (N1)}^5$                  |
| ADuM121N                        |                       |                      |                 |                      |                      |  |
| $I_{DD1(Q)}$                    |                       |                      | 1.0             | 1.5                  | mA                   | $V_I^4 = 0\text{ (NO)}$ , $1\text{ (N1)}^5$                  |
| $I_{DD2(Q)}$                    |                       |                      | 1.0             | 1.4                  | mA                   | $V_I^4 = 0\text{ (NO)}$ , $1\text{ (N1)}^5$                  |
| $I_{DD1(Q)}$                    |                       |                      | 3.9             | 5.8                  | mA                   | $V_I^4 = 1\text{ (NO)}$ , $0\text{ (N1)}^5$                  |
| $I_{DD2(Q)}$                    |                       |                      | 4.8             | 6.4                  | mA                   | $V_I^4 = 1\text{ (NO)}$ , $0\text{ (N1)}^5$                  |
| Dynamic Supply Current          |                       |                      |                 |                      |                      |  |
| Dynamic Input                   | $I_{DDI(D)}$          |                      | 0.01            |                      | mA/Mbps              | Inputs switching, 50% duty cycle                             |
| Dynamic Output                  | $I_{DDO(D)}$          |                      | 0.01            |                      | mA/Mbps              | Inputs switching, 50% duty cycle                             |
| Undervoltage Lockout            |                       |                      |                 |                      |                      |  |
| Positive $V_{DDx}$ Threshold    | $V_{DDxUV+}$          |                      | 1.6             |                      | V                    |  |
| Negative $V_{DDx}$ Threshold    | $V_{DDxUV-}$          |                      | 1.5             |                      | V                    |  |
| $V_{DDx}$ Hysteresis            | $V_{DDxUVH}$          |                      | 0.1             |                      | V                    |  |

| Parameter                                   | Symbol    | Min | Typ | Max | Unit        | Test Conditions/Comments  |
|---|-----------|-----|-----|-----|-------------|---|
| AC SPECIFICATIONS                           |           |     |     |     |             |   |
| Output Rise/Fall Time                       | $t_R/t_F$ |     | 2.5 |     | ns          | 10% to 90%  |
| Common-Mode Transient Immunity <sup>6</sup> | $ CM_H $  | 75  | 100 |     | kV/ $\mu$ s | $V_{ix} = V_{DDx}$ , $V_{CM} = 1000$ V, transient magnitude = 800 V |
|   | $ CM_L $  | 75  | 100 |     | kV/ $\mu$ s | $V_{ix} = 0$ V, $V_{CM} = 1000$ V, transient magnitude = 800 V      |

<sup>1</sup>  $I_{Ox}$  is the Channel x output current, where x = A or B.

<sup>2</sup>  $V_{MH}$  is the input side logic high voltage.

<sup>3</sup>  $V_{ML}$  is the input side logic low voltage.

<sup>4</sup>  $V_i$  is the input voltage.

<sup>5</sup> N0 is the ADuM120N0/ADuM121N0 models, and N1 is the ADuM120N1/ADuM121N1 models. See the Ordering Guide.

<sup>6</sup>  $|CM_H|$  is the maximum common-mode voltage slew rate that can be sustained while maintaining  $V_O > 0.8 V_{DDx}$ .  $|CM_L|$  is the maximum common-mode voltage slew rate that can be sustained while maintaining  $V_O > 0.8$  V. The common-mode voltage slew rates apply to both rising and falling common-mode voltage edges.

**Table 6. Total Supply Current vs. Data Throughput**

| Parameter             | Symbol    | 1 Mbps |     |     | 25 Mbps |     |     | 100 Mbps |     |     | Unit |
|-----------------------|-----------|--------|-----|-----|---------|-----|-----|----------|-----|-----|------|
|                       |           | Min    | Typ | Max | Min     | Typ | Max | Min      | Typ | Max |      |
| SUPPLY CURRENT        |           |        |     |     |         |     |     |          |     |     |      |
| ADuM120N              |           |        |     |     |         |     |     |          |     |     |      |
| Supply Current Side 1 | $I_{DD1}$ | 3.5    | 6.2 |     | 3.9     | 6.6 |     | 5.4      | 9.0 |     | mA   |
| Supply Current Side 2 | $I_{DD2}$ | 1.3    | 1.9 |     | 2.0     | 2.8 |     | 4.2      | 5.8 |     | mA   |
| ADuM121N              |           |        |     |     |         |     |     |          |     |     |      |
| Supply Current Side 1 | $I_{DD1}$ | 2.4    | 4.7 |     | 2.9     | 5.5 |     | 4.5      | 8.0 |     | mA   |
| Supply Current Side 2 | $I_{DD2}$ | 2.9    | 4.9 |     | 3.3     | 5.7 |     | 4.9      | 7.7 |     | mA   |



**ELECTRICAL CHARACTERISTICS—1.8 V OPERATION**

All typical specifications are at  $T_A = 25^\circ\text{C}$ ,  $V_{DD1} = V_{DD2} = 1.8\text{ V}$ . Minimum/maximum specifications apply over the entire recommended operation range:  $1.7\text{ V} \leq V_{DD1} \leq 1.9\text{ V}$ ,  $1.7\text{ V} \leq V_{DD2} \leq 1.9\text{ V}$ , and  $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ , unless otherwise noted. Switching specifications are tested with  $C_L = 15\text{ pF}$  and CMOS signal levels, unless otherwise noted. Supply currents are specified with 50% duty cycle signals.

**Table 7.**

| Parameter                       | Symbol                | Min                  | Typ             | Max                  | Unit                 | Test Conditions/Comments   |
|---------------------------------|-----------------------|----------------------|-----------------|----------------------|----------------------|--|
| <b>SWITCHING SPECIFICATIONS</b> |                       |                      |                 |                      |                      |  |
| Pulse Width                     | PW                    | 6.6                  |                 |                      | ns                   | Within PWD limit   |
| Data Rate                       |                       | 150                  |                 |                      | Mbps                 | Within PWD limit   |
| Propagation Delay               | $t_{PHL}$ , $t_{PLH}$ | 5.8                  | 8.7             | 15                   | ns                   | 50% input to 50% output  |
| Pulse Width Distortion          | PWD                   |                      | 0.7             | 3                    | ns                   | $ t_{PLH} - t_{PHL} $  |
| Change vs. Temperature          |                       |                      | 1.5             |                      | ps/ $^\circ\text{C}$ |  |
| Propagation Delay Skew          | $t_{PSK}$             |                      |                 | 7.0                  | ns                   | Between any two units at the same temperature, voltage, and load |
| Channel Matching                |                       |                      |                 |                      |                      |  |
| Codirectional                   | $t_{PSKCD}$           |                      | 0.7             | 3.0                  | ns                   |  |
| Opposing Direction              | $t_{PSKOD}$           |                      | 0.7             | 3.0                  | ns                   |  |
| Jitter                          |                       |                      | 630             |                      | ps p-p               | See the Jitter Measurement section                               |
|                                 |                       |                      | 190             |                      | ps rms               | See the Jitter Measurement section                               |
| <b>DC SPECIFICATIONS</b>        |                       |                      |                 |                      |                      |  |
| Input Threshold Voltage         |                       |                      |                 |                      |                      |  |
| Logic High                      | $V_{IH}$              | $0.7 \times V_{DDx}$ |                 |                      | V                    |  |
| Logic Low                       | $V_{IL}$              |                      |                 | $0.3 \times V_{DDx}$ | V                    |  |
| Output Voltage                  |                       |                      |                 |                      |                      |  |
| Logic High                      | $V_{OH}$              | $V_{DDx} - 0.1$      | $V_{DDx}$       |                      | V                    | $I_{Ox}^1 = -20\ \mu\text{A}$ , $V_{Ix} = V_{IxH}^2$             |
|                                 |                       | $V_{DDx} - 0.4$      | $V_{DDx} - 0.2$ |                      | V                    | $I_{Ox}^1 = -2\ \text{mA}$ , $V_{Ix} = V_{IxH}^2$                |
| Logic Low                       | $V_{OL}$              |                      | 0.0             | 0.1                  | V                    | $I_{Ox}^1 = 20\ \mu\text{A}$ , $V_{Ix} = V_{IxL}^3$              |
|                                 |                       |                      | 0.2             | 0.4                  | V                    | $I_{Ox}^1 = 2\ \text{mA}$ , $V_{Ix} = V_{IxL}^3$                 |
| Input Current per Channel       | $I_i$                 | -10                  | +0.01           | +10                  | $\mu\text{A}$        | $0\text{ V} \leq V_{Ix} \leq V_{DDx}$                            |
| Quiescent Supply Current        |                       |                      |                 |                      |                      |  |
| ADuM120N                        |                       |                      |                 |                      |                      |  |
| $I_{DD1(Q)}$                    |                       |                      | 0.7             | 1.2                  | mA                   | $V_i^4 = 0\text{ (NO)}$ , $1\text{ (N1)}^5$                      |
| $I_{DD2(Q)}$                    |                       |                      | 1.2             | 1.8                  | mA                   | $V_i^4 = 0\text{ (NO)}$ , $1\text{ (N1)}^5$                      |
| $I_{DD1(Q)}$                    |                       |                      | 6.2             | 9.6                  | mA                   | $V_i^4 = 1\text{ (NO)}$ , $0\text{ (N1)}^5$                      |
| $I_{DD2(Q)}$                    |                       |                      | 1.3             | 1.8                  | mA                   | $V_i^4 = 1\text{ (NO)}$ , $0\text{ (N1)}^5$                      |
| ADuM121N                        |                       |                      |                 |                      |                      |  |
| $I_{DD1(Q)}$                    |                       |                      | 1.0             | 1.5                  | mA                   | $V_i^4 = 0\text{ (NO)}$ , $1\text{ (N1)}^5$                      |
| $I_{DD2(Q)}$                    |                       |                      | 1.0             | 1.4                  | mA                   | $V_i^4 = 0\text{ (NO)}$ , $1\text{ (N1)}^5$                      |
| $I_{DD1(Q)}$                    |                       |                      | 3.8             | 5.8                  | mA                   | $V_i^4 = 1\text{ (NO)}$ , $0\text{ (N1)}^5$                      |
| $I_{DD2(Q)}$                    |                       |                      | 4.7             | 6.4                  | mA                   | $V_i^4 = 1\text{ (NO)}$ , $0\text{ (N1)}^5$                      |
| Dynamic Supply Current          |                       |                      |                 |                      |                      |  |
| Dynamic Input                   | $I_{DDI(D)}$          |                      | 0.01            |                      | mA/Mbps              | Inputs switching, 50% duty cycle                                 |
| Dynamic Output                  | $I_{DDO(D)}$          |                      | 0.01            |                      | mA/Mbps              | Inputs switching, 50% duty cycle                                 |
| Undervoltage Lockout            | UVLO                  |                      |                 |                      |                      |  |
| Positive $V_{DDx}$ Threshold    | $V_{DDxUV+}$          |                      | 1.6             |                      | V                    |  |
| Negative $V_{DDx}$ Threshold    | $V_{DDxUV-}$          |                      | 1.5             |                      | V                    |  |
| $V_{DDx}$ Hysteresis            | $V_{DDxUVH}$          |                      | 0.1             |                      | V                    |  |

| Parameter                                   | Symbol    | Min | Typ | Max | Unit        | Test Conditions/Comments  |
|---|-----------|-----|-----|-----|-------------|---|
| AC SPECIFICATIONS                           |           |     |     |     |             |   |
| Output Rise/Fall Time                       | $t_R/t_F$ |     | 2.5 |     | ns          | 10% to 90%  |
| Common-Mode Transient Immunity <sup>6</sup> | $ CM_H $  | 75  | 100 |     | kV/ $\mu$ s | $V_{ix} = V_{DDx}$ , $V_{CM} = 1000$ V, transient magnitude = 800 V |
|   | $ CM_L $  | 75  | 100 |     | kV/ $\mu$ s | $V_{ix} = 0$ V, $V_{CM} = 1000$ V, transient magnitude = 800 V      |

<sup>1</sup>  $I_{Ox}$  is the Channel x output current, where x = A or B.

<sup>2</sup>  $V_{IH}$  is the input side logic high voltage.

<sup>3</sup>  $V_{IL}$  is the input side logic low voltage.

<sup>4</sup>  $V_i$  is the input voltage.

<sup>5</sup> N0 is the ADuM120N0/ADuM121N0 models, N1 is the ADuM120N1/ADuM121N1 models. See the Ordering Guide.

<sup>6</sup>  $|CM_H|$  is the maximum common-mode voltage slew rate that can be sustained while maintaining  $V_O > 0.8 V_{DDx}$ .  $|CM_L|$  is the maximum common-mode voltage slew rate that can be sustained while maintaining  $V_O > 0.8$  V. The common-mode voltage slew rates apply to both rising and falling common-mode voltage edges.

Table 8. Total Supply Current vs. Data Throughput

| Parameter             | Symbol    | 1 Mbps |     |     | 25 Mbps |     |     | 100 Mbps |     |     | Unit |
|-----------------------|-----------|--------|-----|-----|---------|-----|-----|----------|-----|-----|------|
|                       |           | Min    | Typ | Max | Min     | Typ | Max | Min      | Typ | Max |      |
| SUPPLY CURRENT        |           |        |     |     |         |     |     |          |     |     |      |
| ADuM120N              |           |        |     |     |         |     |     |          |     |     |      |
| Supply Current Side 1 | $I_{DD1}$ |        | 3.4 | 6.0 |         | 3.8 | 6.4 |          | 5.2 | 8.4 | mA   |
| Supply Current Side 2 | $I_{DD2}$ |        | 1.2 | 1.8 |         | 1.9 | 2.8 |          | 4.0 | 5.8 | mA   |
| ADuM121N              |           |        |     |     |         |     |     |          |     |     |      |
| Supply Current Side 1 | $I_{DD1}$ |        | 2.4 | 4.7 |         | 2.8 | 5.5 |          | 4.4 | 7.8 | mA   |
| Supply Current Side 2 | $I_{DD2}$ |        | 2.8 | 4.8 |         | 3.2 | 5.6 |          | 4.8 | 7.9 | mA   |

## INSULATION AND SAFETY RELATED SPECIFICATIONS

For additional information, see [www.analog.com/icouplersafety](http://www.analog.com/icouplersafety).

Table 9.

| Parameter   | Symbol  | Value | Unit        | Test Conditions/Comments   |
|---|---------|-------|-------------|--|
| Rated Dielectric Insulation Voltage   |         | 3000  | V rms       | 1-minute duration  |
| Minimum External Air Gap (Clearance)  | L (I01) | 4.0   | mm min      | Measured from input terminals to output terminals, shortest distance through air   |
| Minimum External Tracking (Creepage)  | L (I02) | 4.0   | mm min      | Measured from input terminals to output terminals, shortest distance path along body                                       |
| Minimum Clearance in the Plane of the Printed Circuit Board (PCB Clearance) | L (PCB) | 4.5   | mm min      | Measured from input terminals to output terminals, shortest distance through air, line of sight, in the PCB mounting plane |
| Minimum Internal Gap (Internal Clearance)                                   |         | 25.5  | $\mu$ m min | Insulation distance through insulation   |
| Tracking Resistance (Comparative Tracking Index)                            | CTI     | >400  | V           | DIN IEC 112/VDE 0303 Part 1  |
| Material Group  |         | II    |             | Material Group (DIN VDE 0110, 1/89, Table 1)   |

## PACKAGE CHARACTERISTICS

Table 10.

| Parameter                                  | Symbol        | Min | Typ       | Max | Unit           | Test Conditions/Comments                            |
|--|---------------|-----|-----------|-----|----------------|---|
| Resistance (Input to Output) <sup>1</sup>  | $R_{I-O}$     |     | $10^{13}$ |     | $\Omega$       |   |
| Capacitance (Input to Output) <sup>1</sup> | $C_{I-O}$     |     | 2         |     | pF             | $f = 1$ MHz   |
| Input Capacitance <sup>2</sup>             | $C_i$         |     | 4.0       |     | pF             |   |
| IC Junction to Ambient Thermal Resistance  | $\theta_{JA}$ |     | 80        |     | $^{\circ}$ C/W | Thermocouple located at center of package underside |

<sup>1</sup> The device is considered a 2-terminal device: Pin 1 through Pin 4 are shorted together, and Pin 5 through Pin 8 are shorted together.

<sup>2</sup> Input capacitance is from any input data pin to ground.

**REGULATORY INFORMATION**

See Table 15 and the Insulation Lifetime section for details regarding recommended maximum working voltages for specific cross-isolation waveforms and insulation levels.

**Table 11.**

| Regulatory Body  | Insulation Parameter  | Insulation Specifications   | Recognition/Approval Program  | File                   |
|--|---|---|---|------------------------|
| UL   | Single protection   | 3000 V rms isolation voltage  | Recognized under UL 1577 Component Recognition Program <sup>1</sup> | File E214100           |
| CSA<br>IEC 62368-1:2014 Edition 2<br>and CSA 62368-1-14<br><br>IEC 60601-1 Edition 3 + A1<br><br>CSA 61010-1-12 and<br>IEC 61010-1 Third Edition | Basic insulation<br><br>Reinforced insulation<br><br>Basic insulation (1 MOPP)<br><br>Basic insulation<br><br>Reinforced insulation | 400 V rms<br><br>200 V rms<br><br>250 V rms<br><br>300 V rms mains, 400 V rms<br><br>300 V rms mains, 200 V secondary | Approved under CSA Component Acceptance Notice                      | File 205078            |
| VDE  | Reinforced insulation   | 565 V peak, $V_{IOSM} = 6250$ V peak  | DIN VDE V 0884-11:2017-01 <sup>2</sup>                              | File 2471900-4880-0003 |
| CQC<br>GB4943.1-2011   | Basic insulation  | 400 V rms (565 V peak) working voltage  | Certified under CQC11-471543-2015                                   | File CQC18001192422    |

<sup>1</sup> In accordance with UL 1577, each ADuM120N/ADuM121N is proof tested by applying an insulation test voltage  $\geq 3600$  V rms for 1 sec.

<sup>2</sup> In accordance with DIN VDE V 0884-11, each ADuM120N/ADuM121N is proof tested by applying an insulation test voltage  $\geq 1059$  V peak for 1 sec (partial discharge detection limit = 5 pC). The \* marking branded on the component designates DIN VDE V 0884-11 approval.

**DIN VDE V 0884-11:2017-01 INSULATION CHARACTERISTICS**

These isolators are suitable for reinforced electrical isolation only within the safety limit data. Protective circuits ensure the maintenance of the safety data. The \* marking on packages denotes DIN VDE V 0884-11 approval.

**Table 12.**

| Description   | Test Conditions/Comments  | Symbol             | Characteristic                  | Unit   |
|---|---|--------------------|---------------------------------|--------|
| Installation Classification per DIN VDE 0110<br>For Rated Mains Voltage ≤ 150 V rms<br>For Rated Mains Voltage ≤ 300 V rms<br>For Rated Mains Voltage ≤ 400 V rms |   |                    | I to IV<br>I to III<br>I to III |        |
| Climatic Classification   |   |                    | 40/105/21                       |        |
| Pollution Degree per DIN VDE 0110, Table 1  |   |                    | 2                               |        |
| Maximum Working Insulation Voltage  |   | V <sub>IORM</sub>  | 565                             | V peak |
| Input to Output Test Voltage, Method B1   | V <sub>IORM</sub> × 1.875 = V <sub>pd(m)</sub> , 100% production test,<br>t <sub>ini</sub> = t <sub>m</sub> = 1 sec, partial discharge < 5 pC | V <sub>pd(m)</sub> | 1059                            | V peak |
| Input to Output Test Voltage, Method A<br>After Environmental Tests Subgroup 1  | V <sub>IORM</sub> × 1.5 = V <sub>pd(m)</sub> , t <sub>ini</sub> = 60 sec, t <sub>m</sub> = 10 sec,<br>partial discharge < 5 pC                | V <sub>pd(m)</sub> | 848                             | V peak |
| After Input and/or Safety Test Subgroup 2<br>and Subgroup 3   | V <sub>IORM</sub> × 1.2 = V <sub>pd(m)</sub> , t <sub>ini</sub> = 60 sec, t <sub>m</sub> = 10 sec,<br>partial discharge < 5 pC                |                    | 678                             | V peak |
| Highest Allowable Overvoltage   |   | V <sub>IOTM</sub>  | 4200                            | V peak |
| Surge Isolation Voltage Reinforced  |   | V <sub>IOSM</sub>  | 6250                            | V peak |
| Safety Limiting Values  | Maximum value allowed in the event of a<br>failure (see Figure 3)   |                    |                                 |        |
| Maximum Junction Temperature  |   | T <sub>s</sub>     | 150                             | °C     |
| Total Power Dissipation at 25°C   |   | P <sub>s</sub>     | 1.56                            | W      |
| Insulation Resistance at T <sub>s</sub>   | V <sub>io</sub> = 500 V   | R <sub>s</sub>     | >10 <sup>9</sup>                | Ω      |

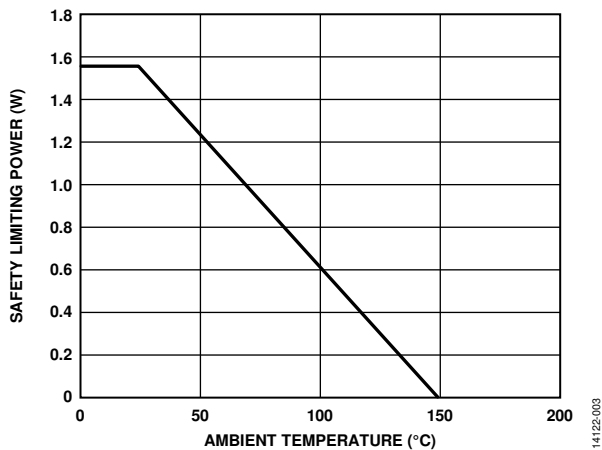


Figure 3. Thermal Derating Curve, Dependence of Safety Limiting Values with Ambient Temperature per DIN VDE V 0884-11

**RECOMMENDED OPERATING CONDITIONS**

**Table 13.**

| Parameter                        | Symbol                              | Rating          |
|----------------------------------|-------------------------------------|-----------------|
| Operating Temperature            | T <sub>A</sub>                      | -40°C to +125°C |
| Supply Voltages                  | V <sub>DD1</sub> , V <sub>DD2</sub> | 1.7 V to 5.5 V  |
| Input Signal Rise and Fall Times |                                     | 1.0 ms          |

## ABSOLUTE MAXIMUM RATINGS

T<sub>A</sub> = 25°C, unless otherwise noted.

Table 14.

| Parameter   | Rating                             |
|---|------------------------------------|
| Supply Voltages (V <sub>DD1</sub> , V <sub>DD2</sub> )            | −0.5 V to +7.0 V                   |
| Input Voltages (V <sub>IA</sub> , V <sub>IB</sub> ) <sup>1</sup>  | −0.5 V to V <sub>DD1</sub> + 0.5 V |
| Output Voltages (V <sub>OA</sub> , V <sub>OB</sub> ) <sup>2</sup> | −0.5 V to V <sub>DDO</sub> + 0.5 V |
| Average Output Current per Pin <sup>3</sup>                       |                                    |
| Side 1 Output Current (I <sub>O1</sub> )                          | −10 mA to +10 mA                   |
| Side 2 Output Current (I <sub>O2</sub> )                          | −10 mA to +10 mA                   |
| Common-Mode Transients <sup>4</sup>                               | −150 kV/μs to +150 kV/μs           |
| Storage Temperature (T <sub>ST</sub> ) Range                      | −65°C to +150°C                    |
| Ambient Operating Temperature (T <sub>A</sub> ) Range             | −40°C to +125°C                    |

<sup>1</sup> V<sub>DD1</sub> is the input side supply voltage.

<sup>2</sup> V<sub>DDO</sub> is the output side supply voltage.

<sup>3</sup> See Figure 3 for the maximum rated current values for various temperatures.

<sup>4</sup> Common-mode transients refer to the common-mode transients across the insulation barrier. Common-mode transients exceeding the absolute maximum ratings can cause latch-up or permanent damage.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

### ESD CAUTION



**ESD (electrostatic discharge) sensitive device.** Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

Table 15. Maximum Continuous Working Voltage<sup>1</sup>

| Parameter             | Rating     | Constraint <sup>2</sup>   |
|-----------------------|------------|---|
| AC VOLTAGE            |            | Lifetime limited by package creepage maximum approved working voltage per IEC 60664-1 |
| Bipolar Waveform      |            |   |
| Basic Insulation      | 789 V peak |   |
| Reinforced Insulation | 403 V peak |   |
| Unipolar Waveform     |            |   |
| Basic Insulation      | 909 V peak |   |
| Reinforced Insulation | 469 V peak |   |
| DC VOLTAGE            |            | Lifetime limited by package creepage maximum approved working voltage per IEC 60664-1 |
| Basic Insulation      | 558 V peak |   |
| Reinforced Insulation | 285 V peak |   |

<sup>1</sup> Maximum continuous working voltage refers to the continuous voltage magnitude imposed across the isolation barrier. See the Insulation Lifetime section for more details.

<sup>2</sup> Insulation lifetime for the specified test condition is greater than 50 years.

### Truth Tables

Table 16. ADuM120N/ADuM121N Truth Table (Positive Logic)

| V <sub>ix</sub> Input <sup>1</sup> | V <sub>DD1</sub> State <sup>1</sup> | V <sub>DDO</sub> State <sup>1</sup> | Default Low (N0), V <sub>Ox</sub> Output <sup>1,2</sup> | Default High (N1), V <sub>Ox</sub> Output <sup>1,2</sup> | Test Conditions/Comments |
|------------------------------------|-------------------------------------|-------------------------------------|---|--|--------------------------|
| Low                                | Powered                             | Powered                             | Low   | Low  | Normal operation         |
| High                               | Powered                             | Powered                             | High  | High   | Normal operation         |
| Don't Care <sup>3</sup>            | Unpowered                           | Powered                             | Low   | High   | Fail-safe output         |
| Don't Care <sup>3</sup>            | Powered                             | Unpowered                           | Indeterminate   | Indeterminate  |                          |

<sup>1</sup> V<sub>ix</sub> and V<sub>Ox</sub> refer to the input and output signals of a given channel (A or B). V<sub>DD1</sub> and V<sub>DDO</sub> refer to the supply voltages on the input and output sides of the given channel, respectively.

<sup>2</sup> N0 is the ADuM120N0/ADuM121N0 models, N1 is the ADuM120N1/ADuM121N1 models. See the Ordering Guide.

<sup>3</sup> Input pins (V<sub>ix</sub>) on the same side as an unpowered supply must be in a low state to avoid powering the device through the ESD protection circuitry.

## PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS



Figure 4. ADuM120N Pin Configuration

Reference the [AN-1109 Application Note](#) for specific layout guidelines.

Table 17. ADuM120N Pin Function Descriptions

| Pin No. | Mnemonic         | Description   |
|---------|------------------|---|
| 1       | V <sub>DD1</sub> | Supply Voltage for Isolator Side 1. This pin requires a 0.01 $\mu$ F to 0.1 $\mu$ F decoupling capacitor. |
| 2       | V <sub>IA</sub>  | Logic Input A.  |
| 3       | V <sub>IB</sub>  | Logic Input B.  |
| 4       | GND <sub>1</sub> | Ground 1. This pin is the ground reference for Isolator Side 1.   |
| 5       | GND <sub>2</sub> | Ground 2. This pin is the ground reference for Isolator Side 2.   |
| 6       | V <sub>OB</sub>  | Logic Output B.   |
| 7       | V <sub>OA</sub>  | Logic Output A.   |
| 8       | V <sub>DD2</sub> | Supply Voltage for Isolator Side 2. This pin requires a 0.01 $\mu$ F to 0.1 $\mu$ F decoupling capacitor. |

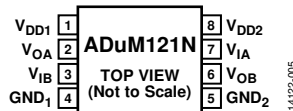


Figure 5. ADuM121N Pin Configuration

Reference the [AN-1109 Application Note](#) for specific layout guidelines.

Table 18. ADuM121N Pin Function Descriptions

| Pin No. | Mnemonic         | Description   |
|---------|------------------|---|
| 1       | V <sub>DD1</sub> | Supply Voltage for Isolator Side 1. This pin requires a 0.01 $\mu$ F to 0.1 $\mu$ F decoupling capacitor. |
| 2       | V <sub>OA</sub>  | Logic Output A.   |
| 3       | V <sub>IB</sub>  | Logic Input B.  |
| 4       | GND <sub>1</sub> | Ground 1. This pin is the ground reference for Isolator Side 1.   |
| 5       | GND <sub>2</sub> | Ground 2. This pin is the ground reference for Isolator Side 2.   |
| 6       | V <sub>OB</sub>  | Logic Output B.   |
| 7       | V <sub>IA</sub>  | Logic Input A.  |
| 8       | V <sub>DD2</sub> | Supply Voltage for Isolator Side 2. This pin requires a 0.01 $\mu$ F to 0.1 $\mu$ F decoupling capacitor. |

### TYPICAL PERFORMANCE CHARACTERISTICS

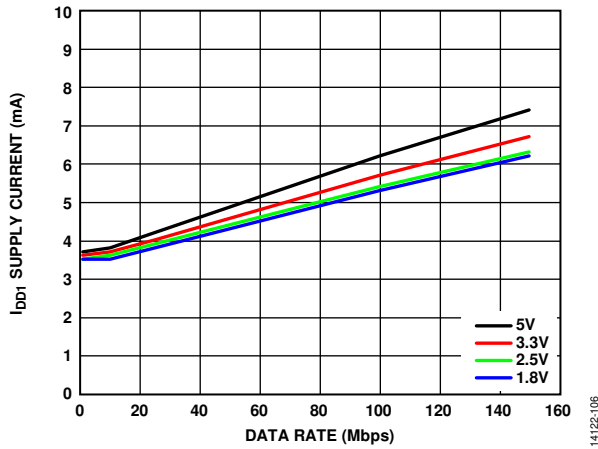


Figure 6. ADuM120N  $I_{DD1}$  Supply Current vs. Data Rate at Various Voltages

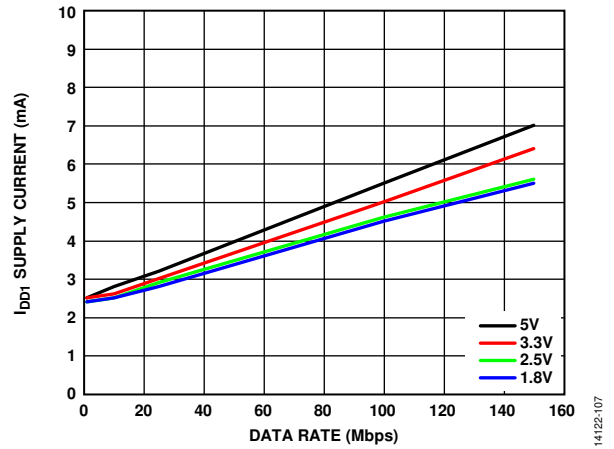


Figure 9. ADuM121N  $I_{DD1}$  Supply Current vs. Data Rate at Various Voltages

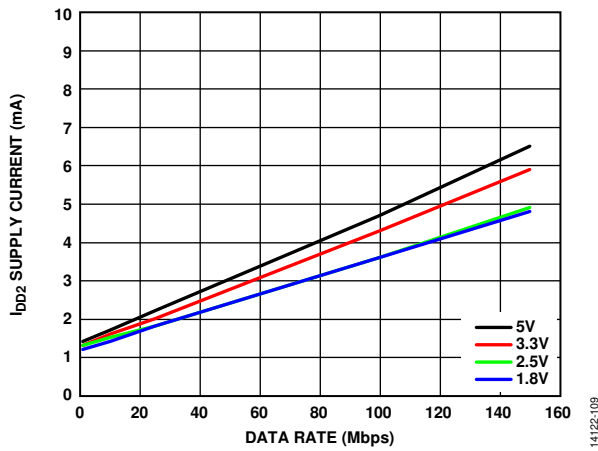


Figure 7. ADuM120N  $I_{DD2}$  Supply Current vs. Data Rate at Various Voltages

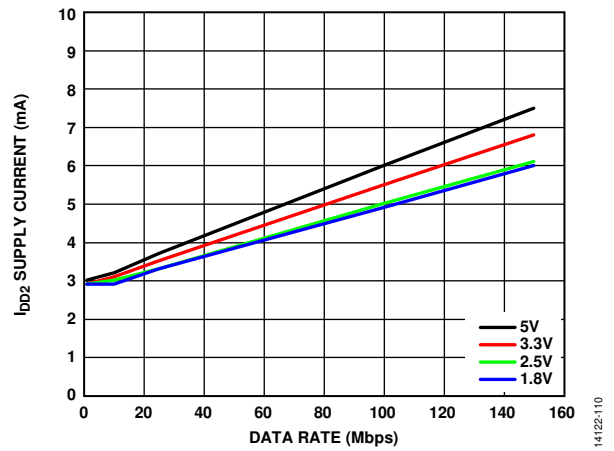


Figure 10. ADuM121N  $I_{DD2}$  Supply Current vs. Data Rate at Various Voltages

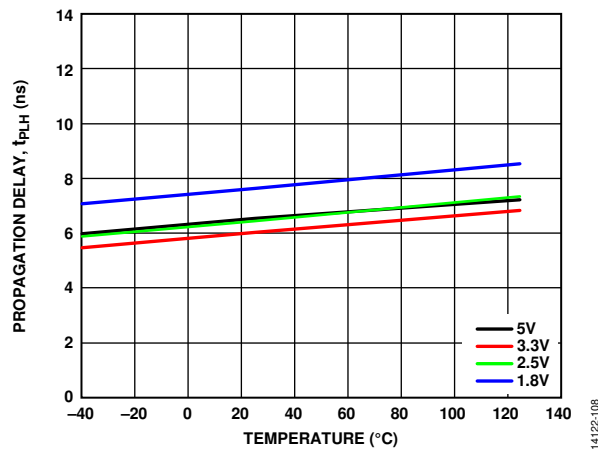


Figure 8. Propagation Delay for Logic High Output ( $t_{PLH}$ ) vs. Temperature at Various Voltages

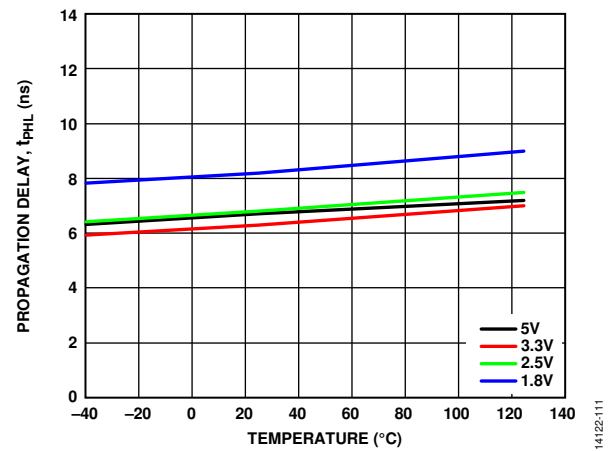


Figure 11. Propagation Delay for Logic Low Output ( $t_{PHL}$ ) vs. Temperature at Various Voltages

## APPLICATIONS INFORMATION

### OVERVIEW

The ADuM120N/ADuM121N use a high frequency carrier to transmit data across an isolation barrier using iCoupler chip scale transformer coils separated by layers of polyimide isolation. With an on/off keying (OOK) technique and the differential architecture shown in Figure 13 and Figure 14, the ADuM120N/ADuM121N have very low propagation delay and high speed. Internal regulators and input/output design techniques allow logic and supply voltages over a wide range from 1.7 V to 5.5 V, offering voltage translation of 1.8 V, 2.5 V, 3.3 V, and 5 V logic. The architecture is designed for high common-mode transient immunity and high immunity to electrical noise and magnetic interference. Radiated emissions are minimized with a spread spectrum OOK carrier and other techniques.

Figure 13 shows the operation block diagram of a single channel for the ADuM120N0/ADuM121N0 models, which have the condition of the fail-safe output state equal to low, where the carrier waveform is off when the input state is low. If the input side is off or not operating, the fail-safe output state of low (noted by the 0 in the model number) sets the output to low. For the ADuM120N1/ADuM121N1, which have a fail-safe output state of high, Figure 14 shows the conditions where the carrier waveform is off when the input state is high. When the input side is off or not operating, the fail-safe output state of high (noted by the 1 in the model number) sets the output to high. See the Ordering Guide for the model numbers that have the fail-safe output state of low or the fail-safe output state of high.

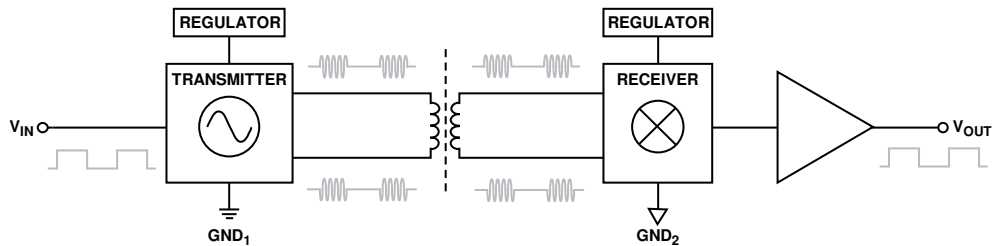


Figure 13. Operational Block Diagram of a Single Channel with a Low Fail-Safe Output State

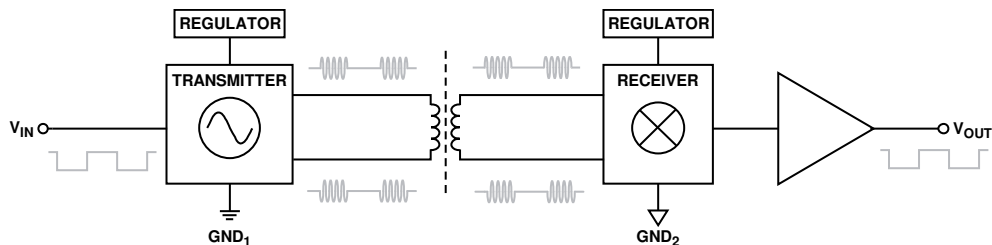


Figure 14. Operational Block Diagram of a Single Channel with a High Fail-Safe Output State

### PCB LAYOUT

The ADuM120N/ADuM121N digital isolators require no external interface circuitry for the logic interfaces. Power supply bypassing is strongly recommended at the input and output supply pins (see Figure 12). Bypass capacitors are most conveniently connected between Pin 1 and Pin 4 for V<sub>DD1</sub> and between Pin 5 and Pin 8 for V<sub>DD2</sub>. The recommended bypass capacitor value is between 0.01 μF and 0.1 μF. The total lead length between both ends of the capacitor and the input power supply pin must not exceed 10 mm.

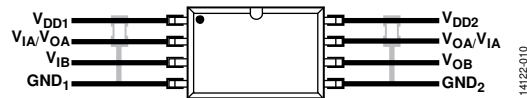


Figure 12. Recommended Printed Circuit Board Layout

In applications involving high common-mode transients, ensure that board coupling across the isolation barrier is minimized. Furthermore, design the board layout such that any coupling that does occur equally affects all pins on a given component side. Failure to ensure this can cause voltage differentials between pins exceeding the Absolute Maximum Ratings of the device, thereby leading to latch-up or permanent damage.

See the AN-1109 Application Note for board layout guidelines.



**PROPAGATION DELAY RELATED PARAMETERS**

Propagation delay is a parameter that describes the time it takes a logic signal to propagate through a component. The propagation delay to a Logic 0 output can differ from the propagation delay to a Logic 1 output.

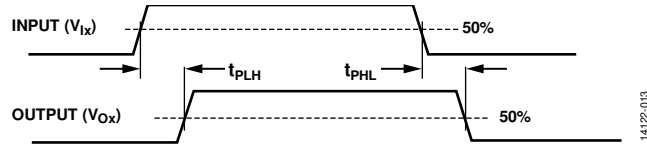


Figure 15. Propagation Delay Parameters

Pulse width distortion is the maximum difference between these two propagation delay values and is an indication of how accurately the timing of the input signal is preserved.

Channel matching is the maximum amount the propagation delay differs between channels within a single ADuM120N/ADuM121N component.

Propagation delay skew is the maximum amount the propagation delay differs between multiple ADuM120N/ADuM121N components operating under the same conditions

**JITTER MEASUREMENT**

Figure 16 shows the eye diagram for the ADuM120N/ADuM121N. The measurement was taken using an Agilent 81110A pulse pattern generator at 150 Mbps with pseudorandom bit sequences (PRBS) 2(n – 1), n = 14, for 5 V supplies. Jitter was measured with the Tektronix Model 5104B oscilloscope, 1 GHz, 10 GS/s with the DPOJET jitter and eye diagram analysis tools. The result shows a typical measurement on the ADuM120N/ADuM121N with 380 ps p-p jitter.

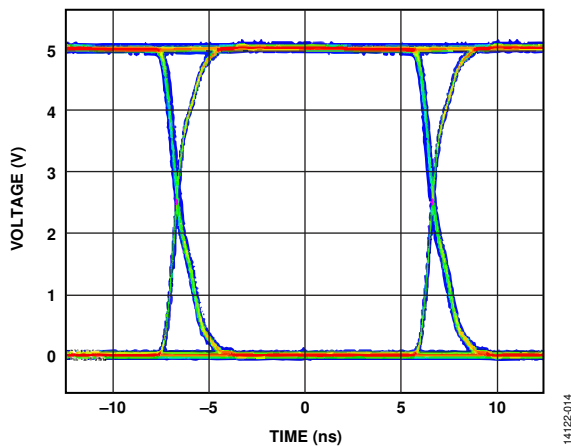


Figure 16. ADuM120N/ADuM121N Eye Diagram

**INSULATION LIFETIME**

All insulation structures eventually break down when subjected to voltage stress over a sufficiently long period. The rate of insulation degradation is dependent on the characteristics of the voltage waveform applied across the insulation as well as on the materials and material interfaces.

The two types of insulation degradation of primary interest are breakdown along surfaces exposed to the air and insulation wear out. Surface breakdown is the phenomenon of surface tracking and the primary determinant of surface creepage requirements in system level standards. Insulation wear out is the phenomenon where charge injection or displacement currents inside the insulation material cause long-term insulation degradation.

**Surface Tracking**

Surface tracking is addressed in electrical safety standards by setting a minimum surface creepage based on the working voltage, the environmental conditions, and the properties of the insulation material. Safety agencies perform characterization testing on the surface insulation of components that allows the components to be categorized in different material groups. Lower material group ratings are more resistant to surface tracking and, therefore, can provide adequate lifetime with smaller creepage. The minimum creepage for a given working voltage and material group is in each system level standard and is based on the total rms voltage across the isolation, pollution degree, and material group. The material group and creepage for the ADuM120N/ADuM121N isolators are presented in Table 9.

**Insulation Wear Out**

The lifetime of insulation caused by wear out is determined by the thickness, material properties, and the voltage stress applied. It is important to verify that the product lifetime is adequate at the application working voltage. The working voltage supported by an isolator for wear out cannot be the same as the working voltage supported for tracking. It is the working voltage applicable to tracking that is specified in most standards.

Testing and modeling show that the primary driver of long-term degradation is displacement current in the polyimide insulation causing incremental damage. The stress on the insulation can be broken down into broad categories, such as dc stress, which causes very little wear out because there is no displacement current, and an ac component time varying voltage stress, which causes wear out.

The ratings in certification documents are usually based on 60 Hz sinusoidal stress because this reflects isolation from line voltage. However, many practical applications have combinations of 60 Hz ac and dc across the barrier as shown in Equation 1. Because only the ac portion of the stress causes wear out, the equation can be rearranged to solve for the ac rms voltage, as is shown in Equation 2. For insulation wear out with the polyimide materials used in these products, the ac rms voltage determines the product lifetime.

$$V_{RMS} = \sqrt{V_{AC\ RMS}^2 + V_{DC}^2} \tag{1}$$

or

$$V_{AC\ RMS} = \sqrt{V_{RMS}^2 - V_{DC}^2} \tag{2}$$

where:

$V_{RMS}$  is the total rms working voltage.

$V_{AC\ RMS}$  is the time varying portion of the working voltage.

$V_{DC}$  is the dc offset of the working voltage.

**Calculation and Use of Parameters Example**

The following example frequently arises in power conversion applications. Assume that the line voltage on one side of the isolation is 240 V<sub>AC RMS</sub> and a 400 V<sub>DC</sub> bus voltage is present on the other side of the isolation barrier. The isolator material is polyimide. To establish the critical voltages in determining the creepage, clearance, and lifetime of a device, see Figure 17 and the following equations.

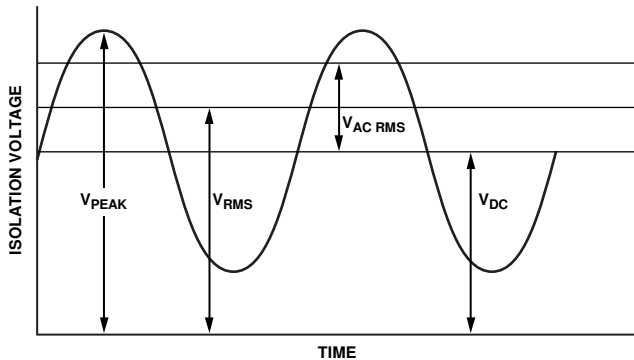


Figure 17. Critical Voltage Example

14122-015

The working voltage across the barrier from Equation 1 is

$$V_{RMS} = \sqrt{V_{AC\ RMS}^2 + V_{DC}^2}$$

$$V_{RMS} = \sqrt{240^2 + 400^2}$$

$$V_{RMS} = 466\ V$$

This is the working voltage used together with the material group and pollution degree when looking up the creepage required by a system standard.

To determine if the lifetime is adequate, obtain the time varying portion of the working voltage. To obtain the ac rms voltage, use Equation 2.

$$V_{AC\ RMS} = \sqrt{V_{RMS}^2 - V_{DC}^2}$$

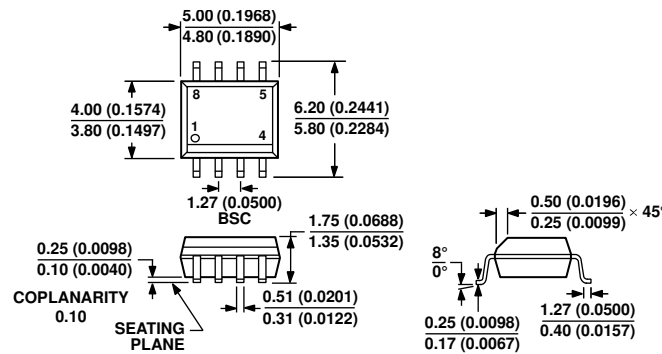
$$V_{AC\ RMS} = \sqrt{466^2 - 400^2}$$

$$V_{AC\ RMS} = 240\ V\ rms$$

In this case, the ac rms voltage is simply the line voltage of 240 V rms. This calculation is more relevant when the waveform is not sinusoidal. The value is compared to the limits for working voltage in Table 15 for the expected lifetime, less than a 60 Hz sine wave, and it is well within the limit for a 50-year service life.

Note that the dc working voltage limit in Table 15 is set by the creepage of the package as specified in IEC 60664-1. This value can differ for specific system level standards.

# OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MS-012-AA  
 CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS  
 (IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR  
 REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

012407-A

Figure 18. 8-Lead Standard Small Outline Package [SOIC\_N]  
 Narrow Body (R-8)  
 Dimensions shown in millimeters and (inches)

## ORDERING GUIDE

| Model <sup>1, 2</sup> | Temperature Range | No. of Inputs, V <sub>DD1</sub> Side | No. of Inputs, V <sub>DD2</sub> Side | Withstand Voltage Rating (kV rms) | Fail-Safe Output State | Package Description          | Package Option |
|-----------------------|-------------------|--------------------------------------|--------------------------------------|-----------------------------------|------------------------|------------------------------|----------------|
| ADuM120N1BRZ          | -40°C to +125°C   | 2                                    | 0                                    | 3                                 | High                   | 8-Lead SOIC_N                | R-8            |
| ADuM120N1BRZ-RL7      | -40°C to +125°C   | 2                                    | 0                                    | 3                                 | High                   | 8-Lead SOIC_N, Tape and Reel | R-8            |
| ADuM120N0BRZ          | -40°C to +125°C   | 2                                    | 0                                    | 3                                 | Low                    | 8-Lead SOIC_N                | R-8            |
| ADuM120N0BRZ-RL7      | -40°C to +125°C   | 2                                    | 0                                    | 3                                 | Low                    | 8-Lead SOIC_N, Tape and Reel | R-8            |
| ADuM120N1WBRZ         | -40°C to +125°C   | 2                                    | 0                                    | 3                                 | High                   | 8-Lead SOIC_N                | R-8            |
| ADuM120N1WBRZ-RL7     | -40°C to +125°C   | 2                                    | 0                                    | 3                                 | High                   | 8-Lead SOIC_N, Tape and Reel | R-8            |
| ADuM120N0WBRZ         | -40°C to +125°C   | 2                                    | 0                                    | 3                                 | Low                    | 8-Lead SOIC_N                | R-8            |
| ADuM120N0WBRZ-RL7     | -40°C to +125°C   | 2                                    | 0                                    | 3                                 | Low                    | 8-Lead SOIC_N, Tape and Reel | R-8            |
| ADuM121N1BRZ          | -40°C to +125°C   | 1                                    | 1                                    | 3                                 | High                   | 8-Lead SOIC_N                | R-8            |
| ADuM121N1BRZ-RL7      | -40°C to +125°C   | 1                                    | 1                                    | 3                                 | High                   | 8-Lead SOIC_N, Tape and Reel | R-8            |
| ADuM121N0BRZ          | -40°C to +125°C   | 1                                    | 1                                    | 3                                 | Low                    | 8-Lead SOIC_N                | R-8            |
| ADuM121N0BRZ-RL7      | -40°C to +125°C   | 1                                    | 1                                    | 3                                 | Low                    | 8-Lead SOIC_N, Tape and Reel | R-8            |
| ADuM121N1WBRZ         | -40°C to +125°C   | 1                                    | 1                                    | 3                                 | High                   | 8-Lead SOIC_N                | R-8            |
| ADuM121N1WBRZ-RL7     | -40°C to +125°C   | 1                                    | 1                                    | 3                                 | High                   | 8-Lead SOIC_N, Tape and Reel | R-8            |
| ADuM121N0WBRZ         | -40°C to +125°C   | 1                                    | 1                                    | 3                                 | Low                    | 8-Lead SOIC_N                | R-8            |
| ADuM121N0WBRZ-RL7     | -40°C to +125°C   | 1                                    | 1                                    | 3                                 | Low                    | 8-Lead SOIC_N, Tape and Reel | R-8            |

<sup>1</sup> Z = RoHS Compliant Part.

<sup>2</sup> W = Qualified for Automotive Applications.

**AUTOMOTIVE PRODUCTS**

The [ADuM121N1WBRZ](#) and the [ADuM121N1WBRZ-RL7](#) models are available with controlled manufacturing to support the quality and reliability requirements of automotive applications. Note that these automotive models may have specifications that differ from the commercial models; therefore, designers should review the Specifications section of this data sheet carefully. Only the automotive grade products shown are available for use in automotive applications. Contact your local Analog Devices account representative for specific product ordering information and to obtain the specific Automotive Reliability reports for these models.